

Search Notes

Application/Control No.

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Examiner

Leon J. Harper

Applicant(s)/Patent under
Reexamination

HASEGAWA ET AL.

Art Unit

2166

SEARCHED

Class	Subclass	Date	Examiner
707	100,104.1, 3,10,20	2/6/2006	LJH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR